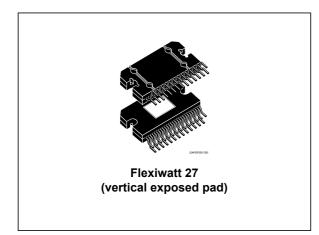


# TDA7562BEP

# 4 x 46 W multifunction quad power amplifier with built-in diagnostics features

#### Datasheet - production data



### Features

- MOSFET output power stage
- High output power capability 4 x 25 W/4 Ω @ 14.4 V, 1 kHz, 10% THD
- Max. output power 4 x 68 W/2 Ω, 4 x 42 W/4 Ω
   @ 14.4 V
- Full I<sup>2</sup>C bus driving:
  - Standby
  - Independent front/rear soft play/mute
  - Selectable gain 30 dB 16 dB

- I<sup>2</sup>C bus digital diagnostics
- Full fault protection
- DC offset detection
- Four independent short circuit protection
- Clipping detector (2% / 10%)
- Standby/mute pin
- ESD protection

### Description

The TDA7562BEP is a new BCD technology quad bridge type of car radio amplifier in a Flexiwatt27 package specially intended for car radio applications.

Thanks to the DMOS output stage the TDA7562BEP has a very low distortion allowing a clear powerful sound.

This device is equipped with a full diagnostics array that communicates the status of each speaker through the  $I^2C$  bus.

The possibility to control the configuration and behavior of the device by means of the  $I^2C$  bus makes the TDA7562BEP a very flexible machine.

#### Table 1. Device summary

Order code	Package	Packing
TDA7562BEP-HLX	Flexiwatt27 (exposed pad)	Tube

This is information on a product in full production.

# Contents

1	Bloc	k diagram and application and test circuit
	1.1	Block diagram
	1.2	Application and test circuit
2	Pin	description
3	Elec	trical specifications
	3.1	Absolute maximum ratings 8
	3.2	Thermal data
	3.3	Electrical characteristics
	3.4	Electrical characteristics curves 12
4	Diag	nostics functional description14
	4.1	Turn-on diagnostic
	4.2	Permanent diagnostics
	4.3	Output DC offset detection 17
	4.4	AC diagnostic
	4.5	Multiple faults
	4.6	Faults availability
	4.7	I <sup>2</sup> C Programming/reading sequence
	4.8	Fast muting
5	App	lication suggestion
	5.1	PC-board hints
6	l <sup>2</sup> C k	ous interface
	6.1	Data validity
	6.2	Start and stop conditions 22
	6.3	Byte format
	6.4	Acknowledge 22
7	Soft	ware specifications



8	Examples of bytes sequence 29
9	Package information 30
	9.1 Flexiwatt 27 (vertical exposed pad) package information
10	Revision history



# List of tables

Table 1.	Device summary
Table 2.	Absolute maximum ratings
Table 3.	Thermal data
Table 4.	Electrical characteristics
Table 5.	Double fault table for turn on diagnostic
Table 6.	IB1
Table 7.	IB2
Table 8.	DB1
Table 9.	DB2
Table 10.	DB3
Table 11.	DB4
Table 12.	Flexiwatt 27 (vertical exposed pad) package mechanical data
Table 13.	Document revision history



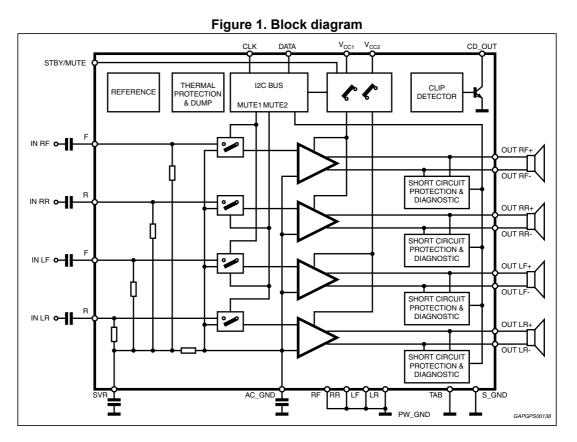
# List of figures

Figure 1.	Block diagram	6
Figure 2.	Application and test circuit	6
Figure 3.	Pin connection (top view)	
Figure 4.	Output power vs. supply voltage (4 $\Omega$ )	
Figure 5.	Output power vs. supply voltage (2 $\Omega$ )	
Figure 6.	Distortion vs. output power (4 $\Omega$ )	12
Figure 7.	Distortion vs. output power (2 $\Omega$ )	
Figure 8.	Distortion vs. frequency (4 $\Omega$ )	
Figure 9.	Distortion vs. frequency $(2 \Omega)$	
Figure 10.	Quiescent current vs. supply voltage	13
Figure 11.	Crosstalk vs. frequency.	13
Figure 12.	Supply voltage rejection vs. frequency	
Figure 13.	Power dissipation and efficiency vs. output power (4 Ω, SINE)	
Figure 14.	Power dissipation vs. average output power (audio program simulation, 4 $\Omega$ )	
Figure 15.	Power dissipation vs. average output power (audio program simulation, 2 $\Omega$ )	
Figure 16.	Turn-on diagnostic: working principle	
Figure 17.	SVR and output behavior (case 1: without turn-on diagnostic)	
Figure 18.	SVR and output pin behavior (case 2: with turn-on diagnostic)	
Figure 19.	Thresholds for short to GND/V <sub>S</sub>	
Figure 20.	Thresholds for short across the speaker/open speaker	
Figure 21.	Thresholds for line-drivers	16
Figure 22.	Restart timing without diagnostic enable (permanent)	
	Each 1 ms time, a sampling of the fault is done	
Figure 23.	Restart timing with diagnostic enable (permanent)	
Figure 24.	Current detection: Load impedance magnitude  Z  Vs. output peak voltage of the sinus	
Figure 25.	Data validity on the I <sup>2</sup> C bus	
Figure 26.	Timing diagram on the I <sup>2</sup> C Bus	
Figure 27.	Timing acknowledge clock pulse	
Figure 28.	Flexiwatt 27 (vertical exposed pad) package outline	30

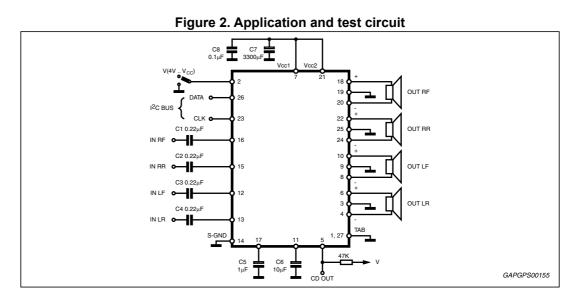


### **1** Block diagram and application and test circuit

### 1.1 Block diagram



### 1.2 Application and test circuit



DocID028961 Rev 1



# 2 Pin description

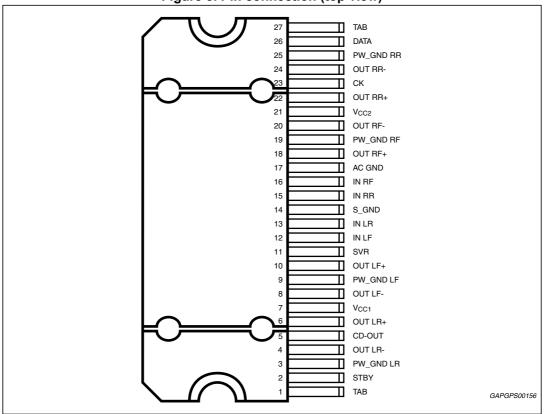


Figure 3. Pin connection (top view)



# 3 Electrical specifications

### 3.1 Absolute maximum ratings

Symbol	Parameter	Value	Unit					
V <sub>op</sub>	Operating supply voltage	18	V					
V <sub>S</sub>	DC supply voltage	28	V					
V <sub>peak</sub>	Peak supply voltage (for t = 50 ms)	50	V					
V <sub>CK</sub>	CK pin voltage	6	V					
V <sub>DATA</sub>	Data pin voltage	6	V					
Ι <sub>Ο</sub>	Output peak current (not repetitive t = 100 $\mu$ s)	8	A					
Ι <sub>Ο</sub>	Output peak current (repetitive f > 10 Hz)	6	Α					
P <sub>tot</sub>	Power dissipation T <sub>case</sub> = 70 °C	85	W					
T <sub>stg</sub> , T <sub>j</sub>	Storage and junction temperature	-55 to 150	°C					
T <sub>op</sub>	Operative temperature range	-40 to 105	°C					

#### Table 2. Absolute maximum ratings

### 3.2 Thermal data

#### Table 3. Thermal data

Symbol	Description	Value Unit		
R <sub>th j-case</sub>	Thermal resistance junction-to-case Max.	1.3	°C/W	



### 3.3 Electrical characteristics

Refer to the test circuit,  $V_S$  = 14.4 V;  $R_L$  = 4  $\Omega$ ; f = 1 kHz;  $G_V$  = 30 dB;  $T_{amb}$  = 25 °C; unless otherwise specified.

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
Power ar	nplifier					
VS	Supply voltage range	-	8	-	18	V
I <sub>d</sub>	Total quiescent drain current	-		150	300	mA
		Max. (V <sub>S</sub> = 15.2 V)	-	46	-	W
P <sub>O</sub>	Output power	THD = 10% THD = 1% Max power	24 18 37	27 22 42	-	W
		$ \begin{array}{l} R_{L} = 2 \; \Omega; \; THD \; 10\% \\ R_{L} = 2 \; \Omega; \; THD \; 1\% \\ R_{L} = 2 \; \Omega; \; max. \; power \end{array} $	38 30 60	45 36 70	-	W
		P <sub>O</sub> = 1 W to 10 W;	-	0.04	0.1	%
THD	Total harmonic distortion	$G_V$ = 16 dB; V <sub>O</sub> = 0.1 to 5 V <sub>RMS</sub>	-	0.02	0.05	%
CT	Cross talk	f = 1 kHz to 10 kHz, $R_G$ = 600 $\Omega$	50	60	-	dB
R <sub>IN</sub>	Input impedance	-	60	100	130	kΩ
G <sub>V1</sub>	Voltage gain 1	-	29	30	31	dB
$\Delta G_{V1}$	Voltage gain match 1	-	-1	0	1	dB
G <sub>V2</sub>	Voltage gain 2	-	15	16	17	dB
E <sub>IN1</sub>	Output noise voltage 1	$R_{g}$ = 600 Ω; 20 Hz to 22 kHz	-	60	100	μV
E <sub>IN2</sub>	Output noise voltage 2	$R_g = 600 \Omega;$ G <sub>V</sub> = 16 dB; 20 Hz to 22 kHz	-	20	30	μV
SVR	Supply voltage rejection	f = 100 Hz to 10 kHz; V <sub>r</sub> = 1 Vpk; R <sub>g</sub> = 600 Ω	50	60	-	dB
BW	Power bandwidth	-	100	-	-	kHz
V <sub>SBY</sub>	Standby/mute pin for standby	-	0	-	1.5	V
V <sub>MU</sub>	Standby/mute pin for mute	-	3.5	-	5	V
V <sub>OP</sub>	Standby/mute pin for operating	-	7	-	V <sub>S</sub>	V
A <sub>SB</sub>	Standby attenuation	-	90	110	-	dB
I <sub>SB</sub>	Standby current	V <sub>SBY</sub> = 0V	-	1	10	μA
A <sub>M</sub>	Mute attenuation	-	80	100	-	dB
V <sub>OS</sub>	Offset voltage	Mute and play	-100	0	100	mV
$V_{AM}$	Min. supply voltage threshold	-	6.5	7.5	8	V
T <sub>ON</sub>	Turn on delay	D2/D1 (IB1) 0 to 1	8	20	50	ms
T <sub>OFF</sub>	Turn off delay	D2/D1 (IB1) 1 to 0	8	20	50	ms



Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
CD <sub>LK</sub>	Clip det high leakage current	CD off	-	0	5	μA
CD <sub>SAT</sub>	Clip det sat. voltage	CD on; I <sub>CD</sub> = 1 mA	-	-	300	mV
00		D0 (IB1) = 0	0.5	2	3	%
CD <sub>THD</sub>	Clip det THD level	D0 (IB1) = 1	5	10	15	%
Turn on o	diagnostics 1 (power amplifier m	ode)				
Pgnd	Short to GND det. (below this limit, the output is considered in short circuit to GND)		-	-	1.2	V
Pvs	Short to Vs det. (above this limit, the output is considered in short circuit to VS)	Power amplifier in standby	Vs -1.2	-	-	V
Pnop	Normal operation thresholds. (Within these limits, the output is considered without faults).	Power amplifier in standby	1.8	-	Vs -1.8	V
Lsc	Shorted load det.	-	-	-	0.5	Ω
Lop	Open load det.	-	85	-	-	Ω
Lnop	Normal load det.	-	1.5	-	45	Ω
Turn on o	diagnostics 2 (line driver mode)					
Pgnd	Short to GND det. (below this limit, the output is considered in short circuit to GND)		-	-	1.2	V
Pvs	Short to Vs det. (above this limit, the output is considered in short circuit to VS)	Power amplifier in standby	Vs -1.2	-	-	V
Pnop	Normal operation thresholds. (within these limits, the output is considered without faults).		1.8	-	Vs -1.8	V
Lsc	Shorted load det.	-	-	-	2	Ω
Lop	Open load det.	-	330	-	-	Ω
Lnop	Normal load det.	-	7	-	180	Ω
Permane	nt diagnostics 2 (power amplifie	r mode or line driver mode)			1 1	
Pgnd	Short to GND det. (below this limit, the output is considered in short circuit to GND)	Power amplifier in mute or play, one or more short circuits protection activated	-	-	1.2	V
Pvs	Short to Vs det. (above this limit, the output is considered in short circuit to VS)	-	Vs -1.2	-	-	V
Pnop	Normal operation thresholds. (Within these limits, the output is considered without faults).	-	1.8	-	Vs -1.8	V

Table 4. Electrical characteristics (	(continued)	
---------------------------------------	-------------	--

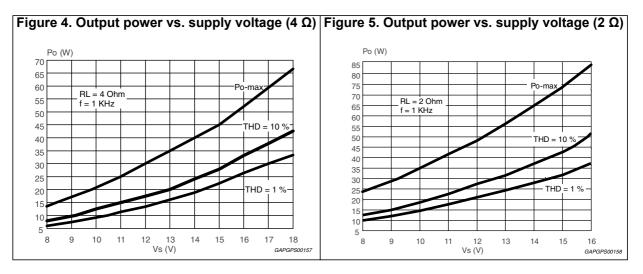


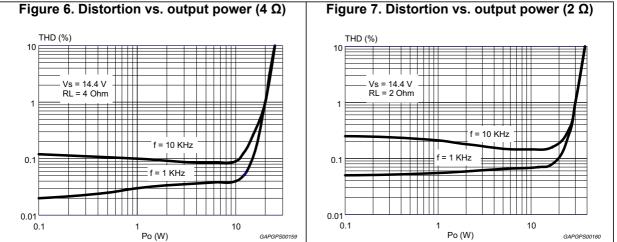
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
	Observations and share	Power amplifier mode	-	-	0.5	Ω
L <sub>SC</sub>	Shorter load det.	Line driver mode	-	-	2	Ω
V <sub>O</sub>	Offset detection	Power amplifier in play, AC Input signals = 0	±1.5	±2	±2.5	V
I <sub>NL</sub>	Normal load current detection	– V <sub>O</sub> < (V <sub>S</sub> - 5)pk	500	-	-	mA
I <sub>OL</sub>	Open load current detection		-	-	250	mA
l <sup>2</sup> C bus ii	nterface					
f <sub>SCL</sub>	Clock frequency	-	-	400	-	kHz
V <sub>IL</sub>	Input low voltage	-	-	-	1.5	V
V <sub>IH</sub>	Input high voltage	-	2.3	-	-	V

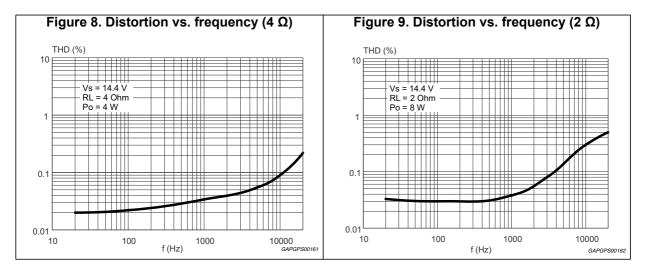
 Table 4. Electrical characteristics (continued)



### 3.4 Electrical characteristics curves

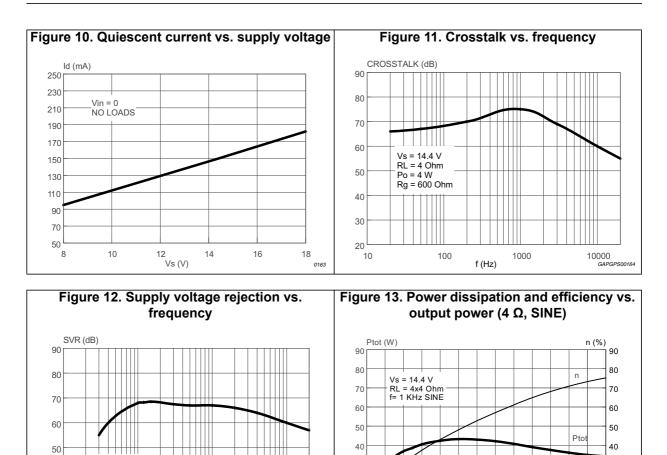


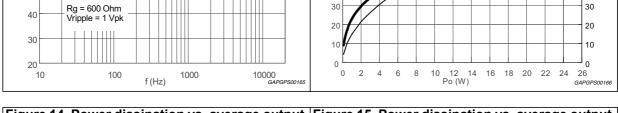




DocID028961 Rev 1

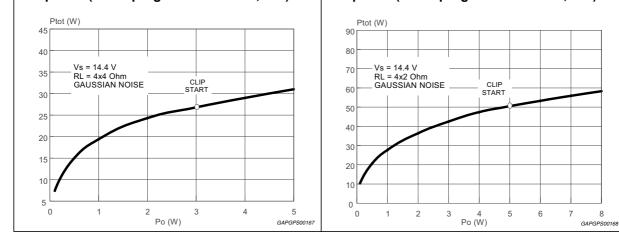






30

Figure 14. Power dissipation vs. average output Figure 15. Power dissipation vs. average output power (audio program simulation, 4  $\Omega$ ) power (audio program simulation, 2  $\Omega$ )





30

### 4 Diagnostics functional description

#### 4.1 Turn-on diagnostic

It is activated at the turn-on (stand-by out) under I<sup>2</sup>C bus request. Detectable output faults are:

- Short to GND
- Short to V<sub>S</sub>
- Short across the speaker
- Open speaker

To verify if any of the above misconnections are in place, a subsonic (inaudible) current pulse (*Figure 16*) is internally generated, sent through the speaker(s) and sunk back. The Turn On diagnostic status is internally stored until a successive diagnostic pulse is requested (after an  $I^2C$  reading).

If the 'standby out' and 'diag. enable' commands are both given through a single programming step, the pulse takes place first (power stage still in stand-by mode, low, outputs = high impedance).

Afterwards, when the Amplifier is biased, the PERMANENT diagnostic takes place. The previous Turn-on state is kept until a short appears at the outputs.

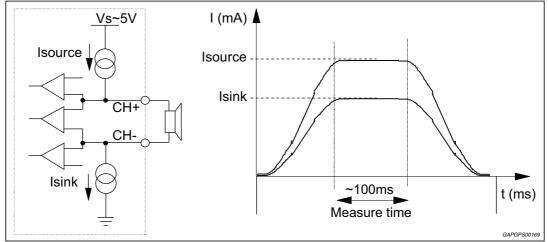


Figure 16. Turn-on diagnostic: working principle

*Figure 17* and *18* show SVR and output waveforms at the turn-on (standby out) with and without turn-on diagnostic.



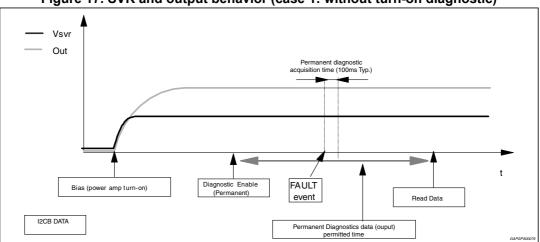
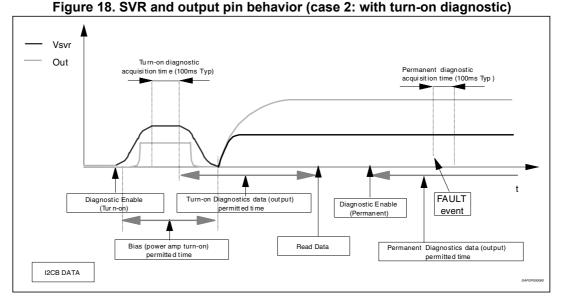
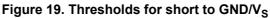


Figure 17. SVR and output behavior (case 1: without turn-on diagnostic)



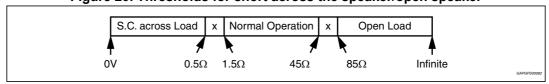
The information related to the outputs status is read and memorized at the end of the current pulse top. The acquisition time is 100 ms (typ.). No audible noise is generated in the process. As for short to GND / Vs the fault-detection thresholds remain unchanged from 30 dB to 16 dB gain setting. They are as follows:



	S.C. to GND	x	Norma	al Operation	x	S.C. to Vs	
	• •	1		4			A
0	V 1.2	V	1.8V	V <sub>S</sub> -1.8V		V <sub>S</sub> -1.2V	٧ <sub>5</sub>

Concerning short across the speaker / open speaker, the threshold varies from 30 dB to 16 dB gain setting, since different loads are expected (either normal speaker's impedance or high impedance). The values in case of 30 dB gain are as follows:





#### Figure 20. Thresholds for short across the speaker/open speaker

If the Line-Driver mode ( $G_v$ = 16 dB and line driver mode diagnostic = 1) is selected, the same thresholds will change as follows:

	S.C. across Lo	bad	x	Norm	al Operation	x	Оре	en Load	
		1	1		4			l	
C	Ω	1.5Ω		7Ω	1809	2 3	330Ω	infi	nite

### 4.2 Permanent diagnostics

Detectable conventional faults are:

- short to GND
- short to Vs
- short across the speaker

The following additional features are provided:

- output offset detection
- AC diagnostic

The TDA7562BEP has 2 operating statuses:

- Restart mode. The diagnostic is not enabled. Each audio channel operates independently from each other. If any of the a.m. faults occurs, only the channel(s) interested is shutdown. A check of the output status is made every 1 ms (*Figure 22*). Restart takes place when the overload is removed.
- 2. Diagnostic mode. It is enabled via I<sup>2</sup>C bus and self activates if an output overload (such as to cause the intervention of the short-circuit protection) occurs to the speakers outputs. Once activated, the diagnostics procedure develops as follows (*Figure 23*):
  - To avoid momentary re-circulation spikes from giving erroneous diagnostics, a check of the output status is made after 1ms: if normal situation (no overloads) is detected, the diagnostic is not performed and the channel returns back active.
  - Instead, if an overload is detected during the check after 1 ms, then a diagnostic cycle having a duration of about 100 ms is started.
  - After a diagnostic cycle, the audio channel interested by the fault is switched to restart mode. The relevant data are stored inside the device and can be read by the microprocessor. When one cycle has terminated, the next one is activated by an I<sup>2</sup>C reading. This is to ensure continuous diagnostics throughout the car-radio operating time.
  - To check the status of the device a sampling system is needed. The timing is chosen at microprocessor level (over half a second is recommended).



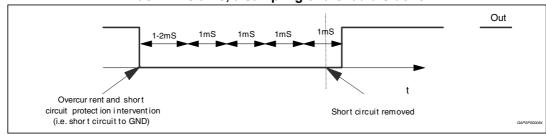
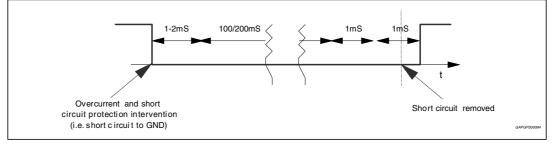


Figure 22. Restart timing without diagnostic enable (permanent) Each 1 ms time, a sampling of the fault is done

#### Figure 23. Restart timing with diagnostic enable (permanent)



### 4.3 Output DC offset detection

Any DC output offset exceeding  $\pm 2$  V is signaled out. This inconvenience might occur as a consequence of initially defective or aged and worn-out input capacitors feeding a DC component to the inputs, so putting the speakers at risk of overheating.

This diagnostic has to be performed with low-level output AC signal (or  $V_{in} = 0$ ).

The test is run with selectable time duration by microprocessor (from a "start" to a "stop" command):

Start = Last reading operation or setting IB1 - D5 - (OFFSET enable) to 1

Stop = Actual reading operation

Offset is signaled out if it lasts for the entire selected time duration. This feature is disabled if any overloads leading to activation of the short-circuit protection occur in the process.



#### 4.4 AC diagnostic

It is targeted at detecting accidental disconnection of tweeters in 2-way speaker and, more in general, presence of capacitive (AC) coupled loads.

This diagnostic is based on the notion that the overall speaker's impedance (woofer + parallel tweeter) will tend to increase towards high frequencies if the tweeter gets disconnected, because the remaining speaker (woofer) would be out of its operating range (high impedance). The diagnostic decision is made according to peak output current thresholds, as follows:

I<sub>out</sub> > 500 mApk = normal status

I<sub>out</sub> < 250 mApk = open tweeter

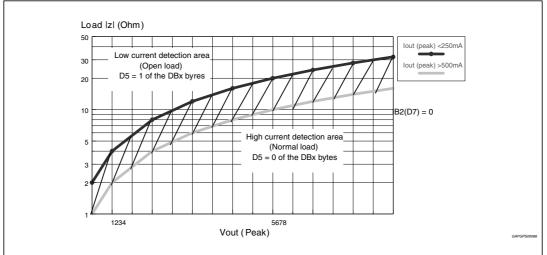
To correctly implement this feature, it is necessary to briefly provide a signal tone (with the amplifier in "play") whose frequency and magnitude are such to determine an output current higher than 500 mApk in normal conditions and lower than 250 mApk should the parallel tweeter be missing. The test has to last for a minimum number of 3 sine cycles starting from the activation of the AC diagnostic function IB2 < D2 > 0 up to the I<sup>2</sup>C reading of the results (measuring period). To confirm the presence of a tweeter, it is necessary to find at least 3 current pulses over 500 mA over all the measuring period, else an "open tweeter" message will be issued.

The frequency / magnitude setting of the test tone depends on the impedance characteristics of each specific speaker being used, with or without the tweeter connected (to be calculated case by case). High-frequency tones (> 10 kHz) or even ultrasonic signals are recommended for their negligible acoustic impact and also to maximize the impedance module's ratio between tweeter-on and tweeter-off.

*Figure 24* shows the Load Impedance as a function of the peak output voltage and the relevant diagnostic fields.

This feature is disabled if any overloads leading to activation of the short-circuit protection occur in the process.

# Figure 24. Current detection: Load impedance magnitude |Z| Vs. output peak voltage of the sinus





#### 4.5 Multiple faults

When more misconnections are simultaneously in place at the audio outputs, it is guaranteed that at least one of them is initially read out. The others are notified after successive cycles of  $I^2C$  reading and faults removal, provided that the diagnostic is enabled. This is true for both kinds of diagnostic (Turn-on and Permanent).

The table below shows all the couples of double-fault possible. It should be taken into account that a short circuit with the 4 ohm speaker unconnected is considered as double fault.

-	S. GND (so)	S. GND (sk)	S. Vs	S. Across L.	Open L.
S. GND (so) <sup>(1)</sup>	S. GND	S. GND	S. Vs + S. GND	S. GND	S. GND
S. GND (sk) <sup>(1)</sup>	1	S. GND	S. Vs	S. GND	Open Load <sup>(2)</sup>
S. Vs	/	1	S. Vs	S. Vs	S. Vs
S. Across L.	1	1	1	S. Across L.	N.A.
Open L.	/	1	/	/	Open Load <sup>(2)</sup>

Table 5. Double fault table for turn on diagnostic

 S. GND (so) / S. GND (sk) in the above table make a distinction according to which of the 2 outputs is shorted to ground (test-current source side= so, test-current sink side = sk). More precisely, in channels LF and LR, so = CH+, sk = CH-; in channels LR and RF, so = CH-, SK = CH+.

 In Permanent Diagnostic the table is the same, with only a difference concerning Open Load, which is not among the recognizable faults. Should an Open Load be present during the device's normal working, it would be detected at a subsequent Turn on Diagnostic cycle (i.e. at the successive Car Radio Turn on).

### 4.6 Faults availability

All the results coming from I<sup>2</sup>C Bus, by read operations, are the consequence of measurements inside a defined period of time. If the fault is stable throughout the whole period, it will be sent out. This is true for DC diagnostic (Turn-on and Permanent), for Offset Detector, for AC Diagnostic (the low current sensor needs to be stable to confirm the Open tweeter).

To always guarantee resident functions, every kind of diagnostic cycles (Turn-on, Permanent, Offset, AC) will be reactivated after any  $I^2C$  reading operation. So, when the micro reads the  $I^2C$ , a new cycle will be able to start, but the read data will come from the previous diag. cycle (i.e. The device is in Turn-on state, with a short to GND, then the short is removed and micro reads  $I^2C$ . The short to GND is still present in bytes, because it is the result of the previous cycle. If another  $I^2C$  reading operation occurs, the bytes do not show the short). In general to observe a change in Diagnostic bytes, two  $I^2C$  reading operations are necessary.



### 4.7 I<sup>2</sup>C Programming/reading sequence

A correct turn on/off sequence respectful of the diagnostic timings and producing no audible noises could be as follows (after battery connection):

TURN-ON: (STANDBY OUT + DIAG ENABLE) --- 500 ms (min) --- MUTING OUT

TURN-OFF: MUTING IN --- 20 ms --- (DIAG DISABLE + STANDBY IN)

Car Radio Installation: DIAG ENABLE (write) --- 200 ms --- I<sup>2</sup>C read (repeat until All faults disappear).

AC TEST: FEED H.F. TONE -- AC DIAG ENABLE (write) --- WAIT > 3 CYCLES ---  $I^2C$  read (repeat  $I^2C$  reading until tweeter-off message disappears).

OFFSET TEST: Device in Play (no signal) -- OFFSET ENABLE - 30ms - I<sup>2</sup>C reading (repeat I<sup>2</sup>C reading until high-offset message disappears).

#### 4.8 Fast muting

The muting time can be shortened to less than 1.5 ms by setting (IB2) D5 = 1. This option can be useful in transient battery situations (i.e. during car engine cranking) to quickly turnoff the amplifier for avoiding any audible effects caused by noise/transients being injected by preamp stages. The bit must be set back to "0" shortly after the mute transition.



### 5 Application suggestion

### 5.1 PC-board hints

The exposed pad package doesn't require any particular care compared with the ST standard Flexiwatt package. For particular PCB configurations, in order to maximize the rejection against any disturbances coming from the battery line (SVR), it is suggested to use one of the following IC metal slug (heat-sink) connections:

- leave the slug simply electrically isolated from the PCB ground;
- in case of 2 layers board, connect the slug to the PCB power ground (P-GND) and not to the signal ground (S-GND).

In case of a PCB with a layer dedicated to grounding (wide / diffused GND area with no distinction between P-GND and S-GND) connect the slug to the common board ground.



# 6 I<sup>2</sup>C bus interface

Data transmission from microprocessor to the TDA7562BEP and voice-overs takes place through the 2 wires  $I^2C$  bus interface, consisting of the two lines SDA and SCL (pull-up resistors to positive supply voltage must be connected).

#### 6.1 Data validity

As shown by *Figure 25*, the data on the SDA line must be stable during the high period of the clock.

The high and low state of the data line can only change when the clock signal on the SCL line is low.

### 6.2 Start and stop conditions

As shown by *Figure 26* a start condition is a high to low transition of the SDA line while SCL is high.

The stop condition is a low to high transition of the SDA line while SCL is high.

#### 6.3 Byte format

Every byte transferred to the SDA line must contain 8 bits. Each byte must be followed by an acknowledge bit. The MSB is transferred first.

#### 6.4 Acknowledge

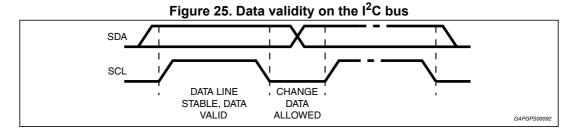
The transmitter (\*) puts a resistive high level on the SDA line during the acknowledge clock pulse (see *Figure 27*). The receiver (\*\*) has to pull-down (LOW) the SDA line during the acknowledge clock pulse, so that the SDA line is stable LOW during this clock pulse.

(\*) Transmitter

- master (µP) when it writes an address to the TDA7562BEP
- slave (TDA7562BEP) when the  $\mu$ P reads a data byte from TDA7562BEP

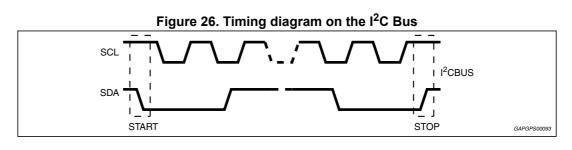
(\*\*) Receiver

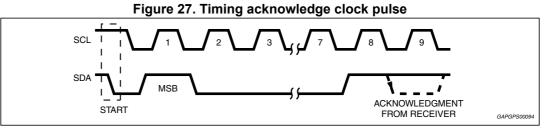
- slave (TDA7562BEP) when the  $\mu$ P writes an address to the TDA7562BEP
- master (µP) when it reads a data byte from TDA7562BEP



DocID028961 Rev 1









### 7 Software specifications

All the functions of the TDA7562BEP are activated by  $\mathsf{I}^2\mathsf{C}$  interface.

The bit 0 of the "ADDRESS BYTE" defines if the next bytes are write instruction (from  $\mu$ P to TDA7562BEP) or read instruction (from TDA7562BEP to  $\mu$ P).

D7							D0	
1	1	0	1	1	0	0	Х	D8 Hex

X = 0 write to device

X = 1 read from device

If R/W = 0, the  $\mu$ P sends 2 "Instruction bytes": IB1 and IB2.

Bit	Instruction decoding bit
D7	0
D6	Diagnostic enable (D6 = 1) Diagnostic defeat (D6 = 0)
D5	Offset Detection enable (D5 = 1) Offset Detection defeat (D5 = 0)
D4	Front Channel Gain = 30 dB (D4 = 0) Gain = 16 dB (D4 = 1)
D3	Rear Channel Gain = 30 dB (D3 = 0) Gain = 16 dB (D3 = 1)
D2	Mute front channels (D2 = 0) Unmute front channels (D2 = 1)
D1	Mute rear channels (D1 = 0) Unmute rear channels (D1 = 1)
D0	CD 2% (D0 = 0) CD 10% (D0 = 1)

#### Table 6. IB1



Bit	Instruction decoding bit
D7	0
D6	0
D5	Normal muting time (D5 = 0) Fast muting time (D5 = 1)
D4	Standby on - Amplifier not working - (D4 = 0) Standby off - Amplifier working - (D4 = 1)
D3	Power amplifier mode diagnostic (D3 = 0) Line driver mode diagnostic (D3 = 1)
D2	Current detection diagnostic enabled (D2 = 1) Current detection diagnostic defeat (D2 = 0)
D1	0
D0	0

#### Table 7. IB2

If R/W = 1, the TDA7562BEP sends 4 "Diagnostics Bytes" to mP: DB1, DB2, DB3 and DB4.

Bit	Instruction decoding bit
D7	Thermal warning active (D7 = 1)
D6	Diag. cycle not activated or not terminated (D6 = 0) Diag. cycle terminated (D6 = 1)
D5	Channel LF Current detection Output peak current < 250 mA - Open load (D5 = 1) Output peak current > 500 mA - Open load (D5 = 0)
D4	Channel LF Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel LF Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel LF Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Offset diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel LF No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel LF No short to GND (D1 = 0) Short to GND (D1 = 1)

Tah	I۸	Q	DB1	
Tap	ie	o.	DBI	



Bit	Instruction decoding bit
D7	Offset detection not activated (D7 = 0) Offset detection activated (D7 = 1)
D6	Current sensor not activated (D6 = 0) Current sensor activated (D6 = 1)
D5	Channel LR Current detection Output peak current < 250 mA - Open load (D5 = 1) Output peak current > 500 mA - Open load (D5 = 0)
D4	Channel LR Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel LR Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel LR Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel LR No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel LR No short to GND (D1 = 0) Short to GND (D1 = 1)

Table 9. DB2



Bit	Instruction decoding bit
D7	Stand-by status (= IB1 - D4)
D6	Diagnostic status (= IB1 - D6)
D5	Channel RF Current detection Output peak current < 250 mA - Open load (D5 = 1) Output peak current > 500 mA - Open load (D5 = 0)
D4	Channel RF Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel RF Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel RF Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel RF No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel RF No short to GND (D1 = 0) Short to GND (D1 = 1)

#### Table 10. DB3



Bit	Instruction decoding bit
D7	X
D6	X
D5	Channel R Current detection Output peak current < 250 mA - Open load (D5 = 1) Output peak current > 500 mA - Open load (D5 = 0)
D4	Channel RR Turn-on diagnostic (D4 = 0) Permanent diagnostic (D4 = 1)
D3	Channel RR Normal load (D3 = 0) Short load (D3 = 1)
D2	Channel RR Turn-on diag.: No open load (D2 = 0) Open load detection (D2 = 1) Permanent diag.: No output offset (D2 = 0) Output offset detection (D2 = 1)
D1	Channel RR No short to Vcc (D1 = 0) Short to Vcc (D1 = 1)
D0	Channel RR No short to GND (D1 = 0) Short to GND (D1 = 1)

Table	11.	DB4
TUDIC		



### 8 Examples of bytes sequence

#### 1 - Turn-on diagnostic - Write operation

Start	Address byte with D0 = 0	ACK	IB1 with D6 = 1	ACK	IB2	ACK	STOP

#### 2 - Turn-on diagnostic - Read operation

Start       Address byte with D0 = 1       ACK       DB1       ACK       DB2       ACK       DB3       ACK       DB4       ACK       STOP	- 2												
		Start	Address byte with D0 = 1	ACK	DB1	ACK	DB2	ACK	DB3	ACK	DB4	ACK	STOP

#### The delay from 1 to 2 can be selected by software, starting from 1ms

**3a** - Turn-on of the power amplifier with 30 dB gain, mute on, diagnostic defeat.

Start	Address byte with D0 = 0	ACK	IB1	ACK	IB2	ACK	STOP
			X000000X		XXX1X0XX		

#### **3b** - Turn-off of the power amplifier

Start	Address byte with D0 = 0	ACK	IB1	ACK	IB2	ACK	STOP
			X0XXXXXX		XXX0XXXX		

#### 4 - Offset detection procedure enable

Start	Address byte with D0 = 0	ACK	IB1	ACK	IB2	ACK	STOP
		-	XX1XX11X		XXX1X0XX		

**5** - Offset detection procedure stop and reading operation (the results are valid only for the offset detection bits (D2 of the bytes DB1, DB2, DB3, DB4).

Start	Address byte with D0 = 1	ACK	DB1	ACK	DB2	ACK	DB3	ACK	DB4	ACK	STOP
-------	--------------------------	-----	-----	-----	-----	-----	-----	-----	-----	-----	------

- The purpose of this test is to check if a D.C. offset (2 V typ.) is present on the outputs, produced by input capacitor with anomalous leakage current or humidity between pins.
- The delay from 4 to 5 can be selected by software, starting from 1ms

**6** - Current detection procedure start (the AC inputs must be with a proper signal that depends on the type of load)

Start	Address byte with D0 = 0	ACK	IB1	ACK	IB2	ACK	STOP
			XX01111X		XXX1X1XX		

**7** - Current detection reading operation (the results valid only for the current sensor detection bits - D5 of the bytes DB1, DB2, DB3, DB4).

Start       Address byte with D0 = 1       ACK       DB1       ACK       DB2       ACK       DB3       ACK       DB4       ACK       STOR
---

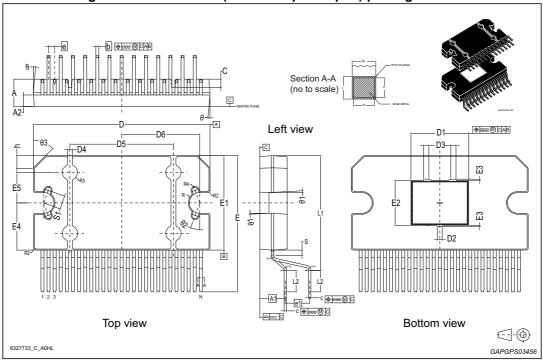
- During the test, a sinus wave with a proper amplitude and frequency (depending on the loudspeaker under test) must be present. The minimum number of periods that are needed to detect a normal load is 5.
- The delay from 6 to 7 can be selected by software, starting from 1ms.



# 9 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

### 9.1 Flexiwatt 27 (vertical exposed pad) package information



#### Figure 28. Flexiwatt 27 (vertical exposed pad) package outline



		att 27 (vertica		nsions		
Ref		Millimeters			Inches <sup>(1)</sup>	
	Min.	Тур.	Max.	Min.	Тур.	Max.
θ		5°			5°	
θ1		3°			3°	
θ2		20°			20°	
θ3		45°			45°	
А	4.45	-	4.65	0.1752	-	0.1831
A1	3.70	-	4.30	0.1457	-	0.1693
A2	1.80	-	2.0	0.0709	-	0.0787
b	0.48	-	0.57	0.0189	-	0.0224
b1	0.46	0.50	0.54	0.0181	0.0197	0.0213
С	0.38	-	0.42	0.0150	-	0.0165
С	-	1.40	-	-	0.0551	-
c1	0.36	0.38	0.40	0.0142	0.0150	-
D <sup>(2)</sup>	28.9	29.23	29.30	1.1378	1.1508	1.1535
D1	9.475	-	9.525	0.3730	-	0.3750
D2	0.80	-	-	0.0315	-	-
D3	0.85	-	-	0.0335	-	-
D4	0.70	0.80	0.90	0.0276	0.0315	0.0354
D5	-	17.00	-	-	0.6693	-
D6	-	12.80	-	-	0.5039	-
е		1.00 BSC			0.0394 BSC	
e1		4.00 BSC			0.1575 BSC	
E	22.07	22.47	22.87	0.8689	0.8846	0.9004
E1 <sup>(2)</sup>	15.50	15.70	15.90	0.6102	0.6181	0.6260
E2	7.375	-	7.425	0.2904	-	0.2923
E3	-	-	0.20	-	-	0.0079
E4	7.70	7.85	7.95	0.3031	0.3091	0.3130
E5	-	5.0	-	-	0.1969	-
h	-	2.0	-	-	0.0787	-
L1	18.57	18.97	19.37	0.7311	0.7469	0.7626
L2	-	3.50	-	-	0.1378	-
Ν		1	2	7	1	
R	-	1.70	-	-	0.0669	-

Table 12. Flexiwatt 27	vertical exp	osed pad)	package	mechanical data
	vertieur exp		package	meenamear aata



			Dimer	nsions			
Ref		Millimeters			Inches <sup>(1)</sup>		
	Min.	Тур.	Max.	Min.	Тур.	Max.	
R1	-	0.50	-	-	0.0197	-	
R2	-	0.30	-	-	0.0118	-	
R3	-	1.25	-	-	0.0492	-	
R4	-	0.50	-	-	0.0197	-	
S	0.75	0.90	1.05	0.0295	0.0354	0.0413	
S1	-	2.20	-	-	0.0866	-	
		Toleran	ce of form and	position			
ccc		0.15			0.0059		
ddd		0.30			0.0118		
eee		0.60			0.0236		
ggg		0.30			0.0118		

#### Table 12. Flexiwatt 27 (vertical exposed pad) package mechanical data (continued)

1. Values in inches are converted from mm and rounded to 4 decimal digits.

2. Dimensions D and E1 include mold flash or protrusions. D and E1 are maximum plastic body size dimensions including mold mismatch.



# 10 Revision history

Date	Revision	Changes
04-Feb-2016	1	Initial release.



#### IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2016 STMicroelectronics – All rights reserved

DocID028961 Rev 1

